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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

**Ralf Peters et al.**

Serial No.: **10/762,563**

Examiner:

Filed : **January 23, 2004**

Group Art Unit: **1724**

For : **MICROFLUIDIC ARRANGEMENT FOR METERING OF LIQUID**

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Upon receipt of the European Search Report, dated April 20, 2004, applicant encloses copies of the documents cited therein, which may be material to the patentability of the claimed subject matter.

A PTO Form-1449 and copies of the documentation, along with a copy of the European Search Report, is enclosed.

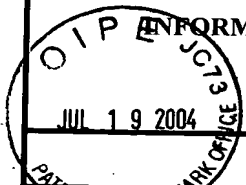
Respectfully submitted,

Date

7/19/04

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**INFORMATION DISCLOSURE CITATION***(Use several sheets if necessary)*

Docket Number (Optional)

**A-8890**

Application Number

**10/762,563**

Applicant(s)

**Ralf Peters et al.**

Filing Date

**January 23, 2004**

Group Art Unit

**1724****U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,230,866	07/23/1993	Shartle et al.			
		6,117,396	09/12/2000	Demers			

**U.S. PATENT APPLICATION PUBLICATIONS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		US 2002/0195463 A1	12/26/2002	Seki et al.			

**FOREIGN PATENT DOCUMENTS**

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
		WO 01/74490 A2	10/11/2001	WIPO			✓	
		WO 01/78893 A2	10/25/2001	WIPO			✓	
		WO 02/11888 A2	02/14/2002	WIPO			✓	

**OTHER DOCUMENTS***(Including Author, Title, Date, Pertinent Pages, Etc.)*


**EXAMINER****DATE CONSIDERED**

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.